

**Search Notes**

Application/Control No.

10/618,297

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

WANG ET AL.

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	215, 559.4	12/23/2005	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search		1/3/2006	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	8/31/2005	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/23/2005	PL